Notice of References Cited Application/Control No. 10/643,078 Applicant(s)/Patent Under Reexamination NAKAZAWA ET AL. Examiner David Q. Nguyen Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,646,449	11-2003	Seppinen et al.	324/624
*	В	US-6,292,519	09-2001	Popovic, Branislav M.	375/346
*	С	US-6,885,694	04-2005	He et al.	375/144
*	D	US-2005/0032472	02-2005	Jiang et al.	455/013.4
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.